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# EMC Test Report

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Report No.: AGC03507190310EE01

**PRODUCT DESIGNATION** : Laser pointer touch pen  
**BRAND NAME** : N/A  
**MODEL NAME** : M08097  
**CLIENT** : MID OCEAN BRANDS B.V  
**DATE OF ISSUE** : Mar.21, 2019  
**STANDARD(S)** : EN 55015:2013+A1:2015  
: EN 61547:2009  
**REPORT VERSION** : V1.0

Attestation of *Global Compliance (Shenzhen) Co., Ltd*

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**REPORT REVISE RECORD**

<b>Report Version</b>	<b>Revise Time</b>	<b>Issued Date</b>	<b>Valid Version</b>	<b>Notes</b>
V1.0	/	Mar.21, 2019	Valid	Initial release

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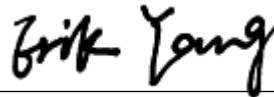
## 1. VERIFICATION OF CONFORMITY

<b>Applicant</b>	MID OCEAN BRANDS B.V
<b>Address</b>	7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong.
<b>Manufacturer</b>	MID OCEAN BRANDS B.V
<b>Address</b>	7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong.
<b>Factory</b>	MID OCEAN BRANDS B.V
<b>Address</b>	7/F, Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong.
<b>Product Designation</b>	Laser pointer touch pen
<b>Brand Name</b>	N/A
<b>Test Model</b>	MO8097
<b>Date of test</b>	Mar.18, 2019 to Mar.20, 2019
<b>Deviation</b>	None
<b>Condition of Test Sample</b>	Normal
<b>Test Result</b>	Pass
<b>Report Template</b>	AGCRT-EC-LT/DC(2013-03-01)

The above equipment was tested by Attestation of Global Compliance (Shenzhen) Co., Ltd. for compliance with the requirements set forth in the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Tested By



Erik Yang(Yang Jianmin)

Mar.21, 2019

Reviewed By



Stone Zhou(Zhou Dong)

Mar.21, 2019

Approved By



Forrest Lei(Lei Yonggang)  
Authorized Officer

Mar.21, 2019

## 2. SYSTEM DESCRIPTION

TEST MODE DESCRIPTION		
NO.	TEST MODE DESCRIPTION	WORST
1	Light on mode	V

Note: 1.V means EMI worst mode.

## 3. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by ISO.

- Uncertainty of Radiated Emission,  $U_c = \pm 3.9\text{dB}$

#### 4. PRODUCT INFORMATION

<b>Housing Type</b>	Plastic and metal
<b>EUT Input Rating</b>	DC 4.5V by battery

I/O Port Information (Applicable Not Applicable)

I/O Port of EUT			
I/O Port Type	Number	Cable Description	Tested With
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## 5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Serial No.	Data Cable	Power Cable
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**Note:**

1. "--" means no any support device during testing.

## 6. TEST FACILITY

<b>Site</b>	Attestation of Global Compliance (Shenzhen) Co., Ltd
<b>Location</b>	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao 'an District, Shenzhen, Guangdong, China

### TEST EQUIPMENT OF RADIATED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
TEST RECEIVER	R&S	ESCI	10096	Jun.12, 2018	Jun.11, 2019
ANTENNA	SCHWARZBECK	VULB9168	D69250	Sep.28, 2017	Sep.27, 2019

### TEST EQUIPMENT OF ESD TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
ESD Simulator	Schaffner	NSG 438	782	Oct.25, 2018	Oct.24, 2019

### TEST EQUIPMENT OF RS IMMUNITY TEST

Description	Manufacturer	Model	S/N	Cal. Date	Cal. Due
SIGNAL GENERATOR	R&S	E4421B	MY4335160 3	May.15, 2018	May.14, 2019
ANTENNA	SCHWARZBCK	VULB9168	D69250	Sep.28, 2017	Sep.27, 2019
POWER SENSOR	R&S	URV5-Z4	100124	May.15, 2018	May.14, 2019
POWER METER	R&S	NRVD	8323781027	May.15, 2018	May.14, 2019
POWER AMPLIFIER	KALMUS	7100LC	04-02/17- 06-001	Jun.12, 2018	Jun.11, 2019
RF AMPLIFIER	Milmega	AS0104- 55_55	1004793	Jun.12, 2018	Jun.11, 2019
HORN ANTENNA	ETS LINDGREN	3117	00034609	May.26, 2018	May.25, 2019
Power Amplifier	rflight	NTWPA- 2560100	17063183	Oct.18, 2018	Oct.17, 2019
Broadband High Gain Horn Antenna	SCHWARZBECK	BBHA 9120 J	00073	Mar.19, 2018	Mar.18, 2020

### TEST EQUIPMENT OF PFMF TEST

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
PFMF system	HTEC	HPFMF	161701	Aug.28 2018	Aug.27, 2019



## 7. TEST ITEMS AND THE RESULTS

Test item	Test Requirement	Test Method	Class/Severity	Result
CONDUCTED EMISSION	EN 55015	EN 55015	0.009MHz -30MHz	N/A
RADIATED EMISSION	EN 55015	EN 55015	30MHz -300MHz	Pass
RADIATED ELECTROMAGNETIC DISTURBANCE	EN 55015	EN 55015	0.009MHz -30MHz	N/A
Harmonic current emission	EN 61000-3-2	EN 61000-3-2	Class C	N/A
Voltage fluctuations & flicker	EN 61000-3-3	EN 61000-3-3	§5 of EN 61000-3-3	N/A
Electrostatic Discharge Immunity	EN 61547	EN 61000-4-2	± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge)	Pass
Radiated RF Electromagnetic	EN 61547	EN 61000-4-3	3V/m with 80% AM. 1kHz Modulation.	Pass
Electrical fast transient/burst Immunity	EN 61547	EN 61000-4-4	+/- 1kV for Power Supply Lines	N/A
SURGE IMMUNITY	EN 61547	EN 61000-4-5	>25W +/-1kV (Line to Line) +/-2kV (Line to Ground) ≤25W +/-0.5kV (Line to Line) +/-1kV (Line to Ground)	N/A
Immunity to Conducted Disturbances Induced by RF fields	EN 61547	EN 61000-4-6	3V with 80% AM. 1 kHz Modulation	N/A
Power Frequency Magnetic Fields	EN 61547	EN61000-4-8	50/60 Hz, 3A/m	Pass
Voltage dips and short interruptions immunity	EN 61547	EN 61000-4-11	PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees	N/A

**Note:** N/A means not applicable.

## 8. EN 55015 RADIATED EMISSION TEST

### 8.1. LIMITS OF RADIATED DISTURBANCES

#### AT 10M DISTANCES

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBuV/m Q.P.)
30-230	10	30.00
230-300	10	37.00

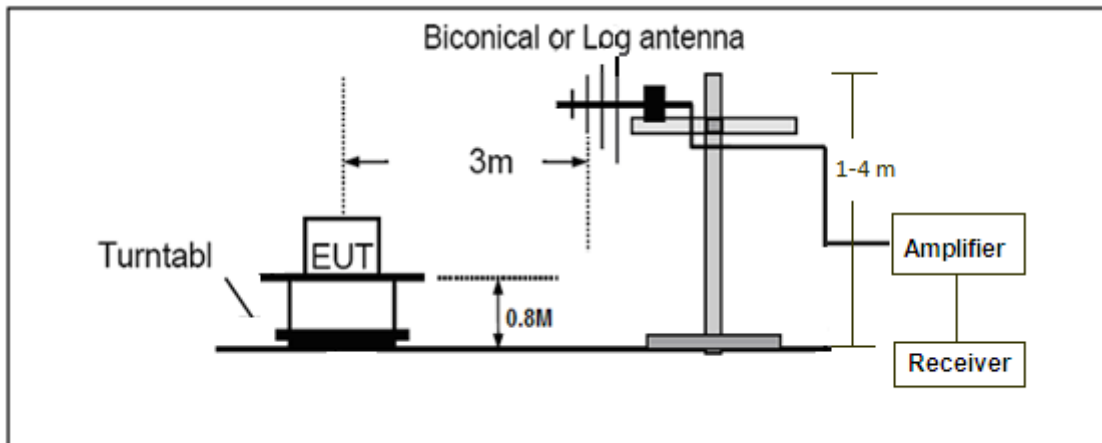
#### AT 3M DISTANCES

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBuV/m Q.P.)
30-230	3	40.00
230-300	3	47.00

Note: The lower limit shall apply at the transition frequency.

### 8.2. BLOCK DIAGRAM OF TEST SETUP

System Diagram of Connections between EUT and Simulators

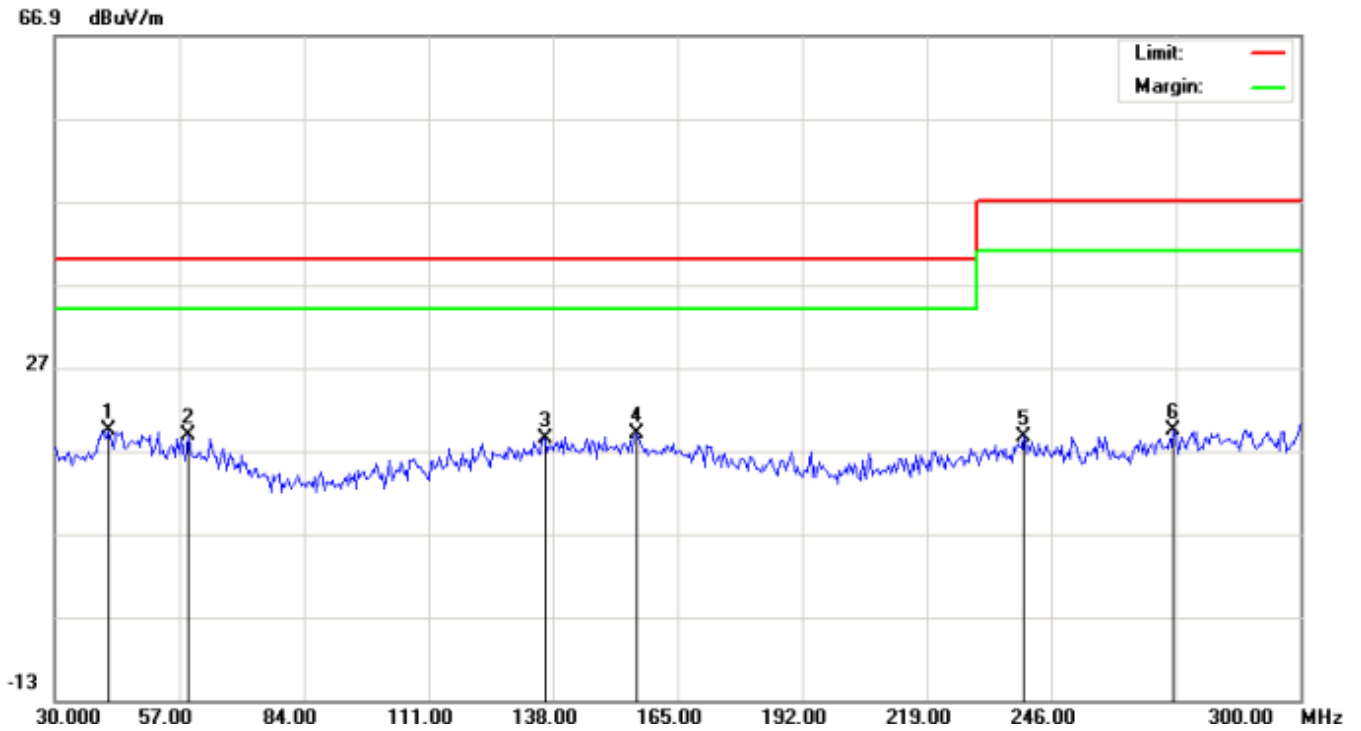


### 8.3. PROCEDURE OF RADIATED EMISSION TEST

- (1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55015 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- (2) Support equipment, if needed, was placed as per EN 55015.
- (3) All I/O cables were positioned to simulate typical actual usage as per EN 55015.
- (4) The EUT was turned on.
- (5) The antenna was placed at 3 meters away from the EUT as stated in EN 55015. The antenna connected to the Analyzer via a cable and at times a pre-amplifier would be used.
- (6) The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- (7) The test mode(s) were scanned during the test:
- (8) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and Q.P./Peak reading is presented.

### 8.4. TEST RESULT OF RADIATED EMISSION TEST

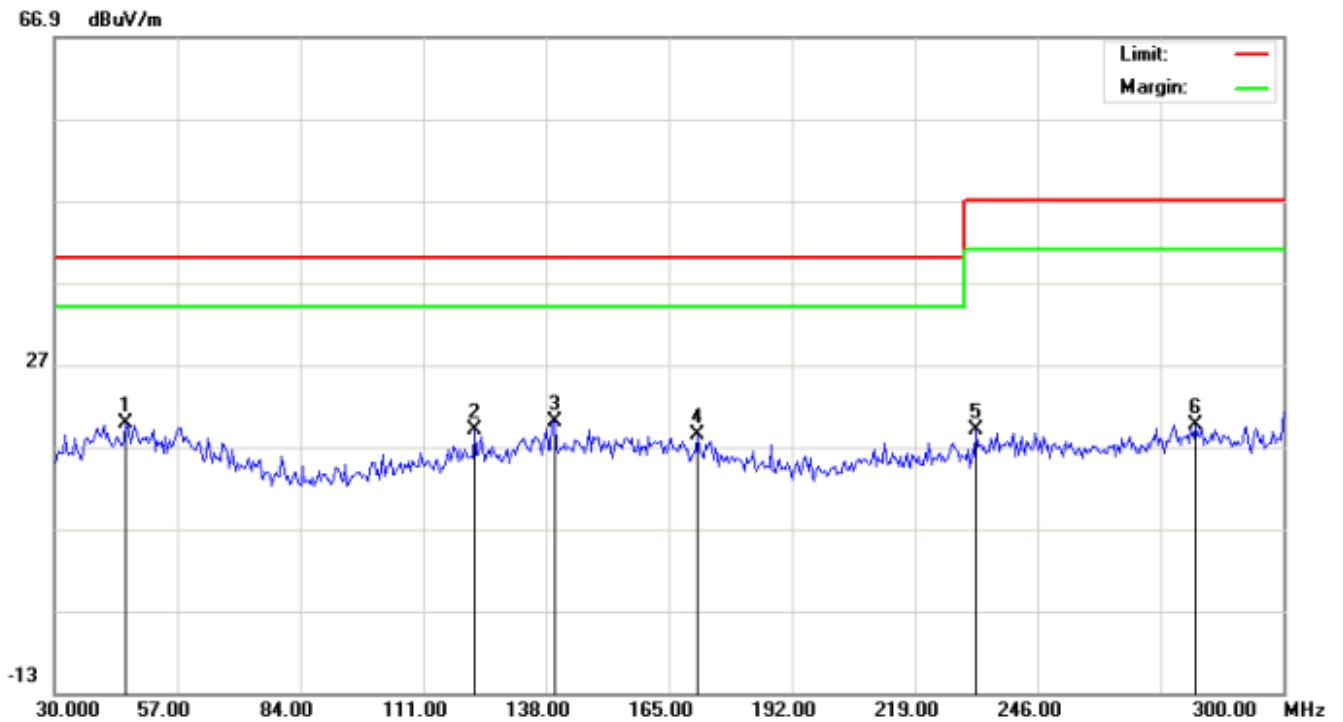
Radiated Emission Test at 3m Distance-Horizontal



No.	Mk	Freq.	Reading	Factor	Measurement	Limit	Over	Detector
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	
1	*	41.7000	-0.63	20.03	19.40	40.00	-20.60	peak
2		58.8000	-0.23	18.97	18.74	40.00	-21.26	peak
3		136.2000	-0.56	18.99	18.43	40.00	-21.57	peak
4		156.0000	-0.11	19.20	19.09	40.00	-20.91	peak
5		240.1500	0.04	18.66	18.70	47.00	-28.30	peak
6		272.5500	-0.02	19.33	19.31	47.00	-27.69	peak

**RESULT: PASS**

Radiated Emission Test at 3m Distance-Vertical



No.	Mk	Freq.	Reading	Factor	Measurement	Limit	Over	Detector
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	
1		45.7500	-0.14	19.88	19.74	40.00	-20.26	peak
2		122.2500	0.97	18.11	19.08	40.00	-20.92	peak
3	*	139.8000	0.79	19.22	20.01	40.00	-19.99	peak
4		171.3000	0.47	18.03	18.50	40.00	-21.50	peak
5		232.5000	0.90	18.13	19.03	47.00	-27.97	peak
6		280.6500	-0.37	19.92	19.55	47.00	-27.45	peak

**RESULT: PASS**

Note:

Measurement (dBuV/m)=Reading(dBuV)+Factor(dB/m)

Factor(dB/m)=Antenna Factor(dB/m)+Cable loss(dB)+Attenuation(dB)for Attenuator

Over= Measurement-Limit

## 9. EN 55015 RADIATED ELECTROMAGNETIC DISTURBANCE TEST

### 9.1. LIMITS OF RADIATED ELECTROMAGNETIC DISTURBANCE IN THE RANGE 9 KHZ TO 30 MHZ

Frequency Range	Limits for Loop Diameter dB(uA)*		
	2m	3m	4m
9 KHz-70 KHz	88*	81*	75*
70 KHz-150 KHz	88 to 58**	81 to 51**	75 to 45**
150 kHz-3.0 MHz	58 to 22**	51 to 15**	45 to 9**
3.0 MHz-30 MHz	22***	15 to 16***	9 to 12***

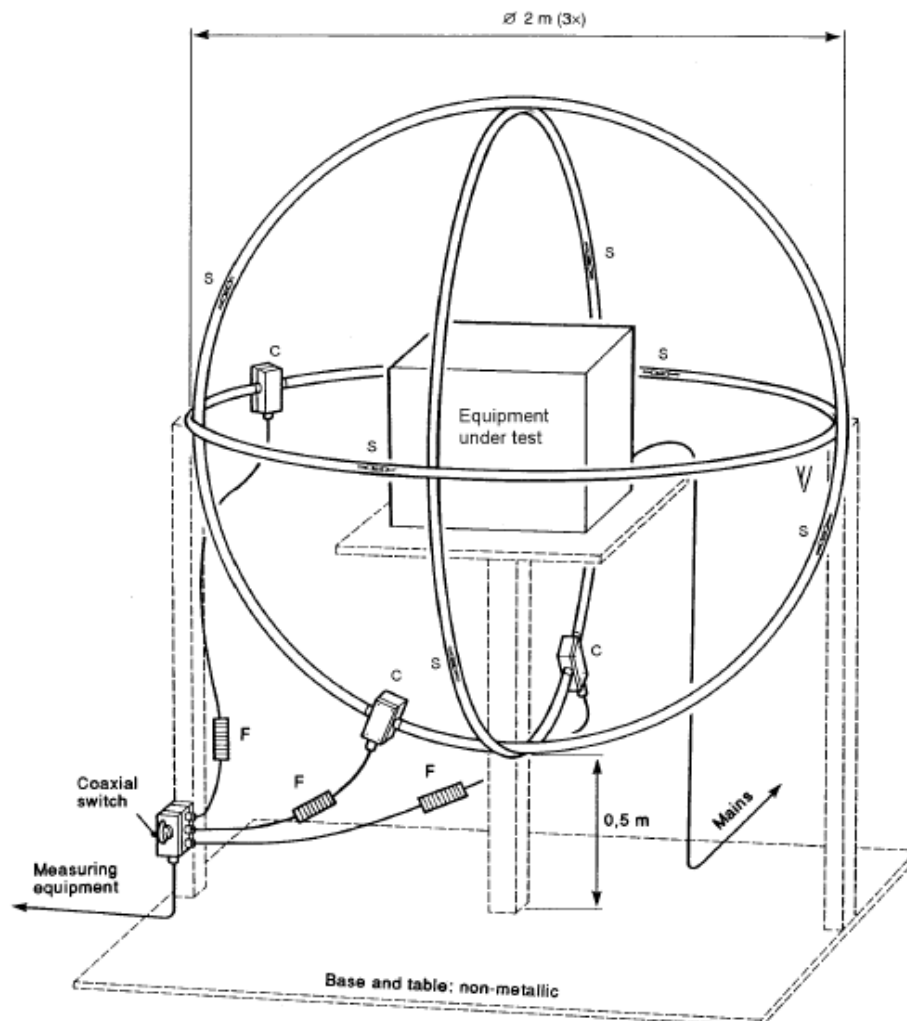
Note:

\*At the transition frequency, the lower limit applies.

\*\* Decreasing linearly with the logarithm of the frequency. For electrode less lamps and luminaries, the limit in the frequency range of 2.2 MHz to 3.0 MHz is 58 dB(uA) for 2m, 51 dB(uA) for 3m and 45 dB(uA) for 4m loop diameter.

\*\*\* Increasing linearly with the logarithm of the frequency.

## 9.2. BLOCK DIAGRAM OF TEST SETUP



## 9.3. TEST PROCEDURE

The magnetic component shall be measured by means of a loop antenna as described in EN 55015. The lighting equipment shall be placed in the centre of the antenna, and the position is not critical.

The test object was operated at its upper limit of its rated voltage and its rated frequency. The induced current in the loop antenna is measured by means of a current probe (1V/A) and the CISPR measuring receiver. By means of a coaxial switch the three field directions can be measured in sequence. Each value shall fulfill the requirements given.

## 9.4. RESULT

**Note:** Owing to the operating frequency of EUT is less than 100Hz, so test is not applicable.

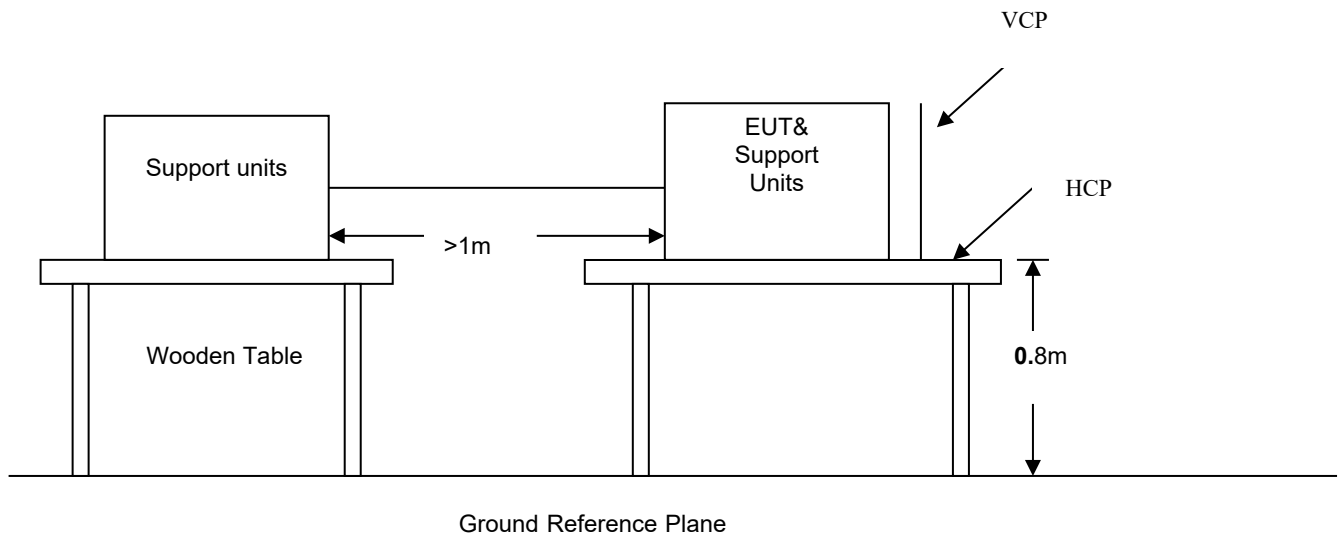
## 10. EN 61000-4-2 ESD IMMUNITY TEST

### ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

<b>Port</b>	Enclosure
<b>Basic Standard</b>	EN 61000-4-2
<b>Test Level</b>	± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge)
<b>Standard require</b>	B
<b>Tester</b>	Erik
<b>Temperature</b>	24 °C
<b>Humidity</b>	53%

#### 10.1. BLOCK DIAGRAM OF TEST SETUP

(The 470 k ohm resistors are installed per standard requirement)





## 10.2. TEST PROCEDURE

The EUT was located 0.1 m minimum from all side of the HCP.

The support units were located 1 m minimum away from the EUT.

EUT worked with resistance load, and make sure EUT worked normally.

Activates the communication function if the EUT with such port(s).

As per the requirement of EN 61547: Contact discharge is the preferred test method, twenty discharges (10 with positive and 10 with negative polarity) shall be applied on each accessible metallic part of the enclosure, terminals are excluded. Air discharges shall be used where contact discharges cannot be applied. Discharges shall be applied on the horizontal or vertical coupling planes as specified in EN 61000-4-2.

The following test condition was followed during the tests.

**Note:** As per the A2 to EN 61000-4-2, a bleed resistor cable is connected between the EUT and HCP during the test.

The electrostatic discharges were applied as follows:

Voltage	Coupling	Test Performance	Result
±4kV	Contact Discharge	No function loss	A
±4kV	Indirect Discharge HCP (Front)	No function loss	A
±4kV	Indirect Discharge HCP (Left)	No function loss	A
±4kV	Indirect Discharge HCP (Back)	No function loss	A
±4kV	Indirect Discharge HCP (Right)	No function loss	A
±4kV	Indirect Discharge VCP (Front)	No function loss	A
±4kV	Indirect Discharge VCP (Left)	No function loss	A
±4kV	Indirect Discharge VCP (Back)	No function loss	A
±4kV	Indirect Discharge VCP (Right)	No function loss	A
±8kV	Air Discharge	No function loss	A

## 10.3. PERFORMANCE & RESULT

<b>Criteria A:</b>	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
<b>Criteria B:</b>	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
<b>Criteria C:</b>	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**PASS**

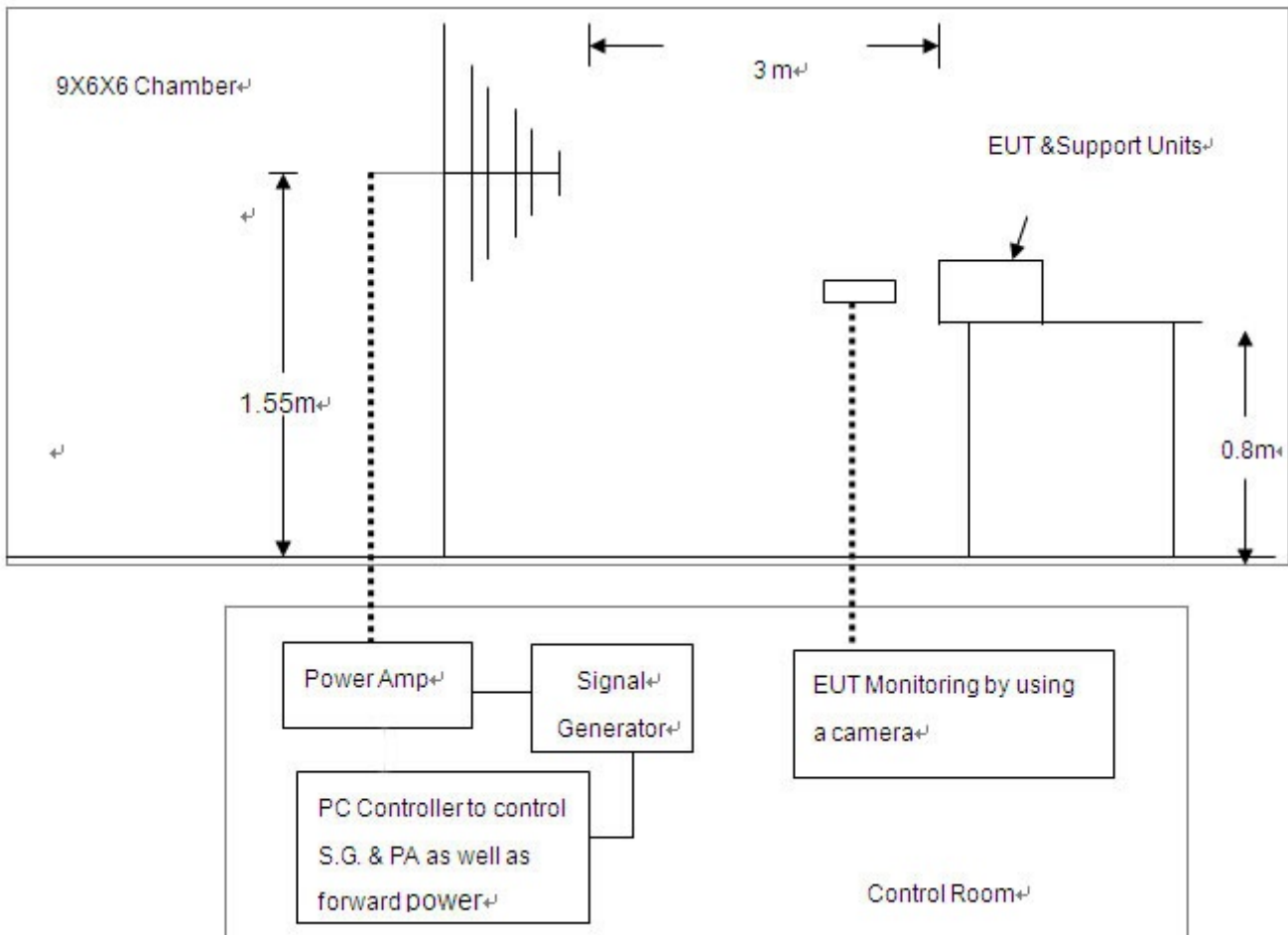
**FAIL**

## 11. EN 61000-4-3 RS IMMUNITY TEST

### RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

<b>Port</b>	Enclosure
<b>Basic Standard</b>	EN 61000-4-3
<b>Test Level:</b>	3V/m with 80% AM. 1kHz Modulation.
<b>Standard require</b>	A
<b>Tester</b>	Erik
<b>Temperature</b>	23°C
<b>Humidity</b>	54%

#### 11.1. BLOCK DIAGRAM OF TEST SETUP



### 11.2. TEST PROCEDURE

The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per EN 61000-4-3.

EUT worked with resistance load, and make sure EUT worked normally.

Setting the testing parameters of RS test software per EN 61000-4-3.

Performing the test at each side of with specified level (3V/m) at 1% steps and test frequency from 80MHz to 1000MHz

Recording the test result in following table.

#### EN 61000-4-3 Final test conditions:

Test level: 3V/m

Steps: 1 % of fundamental

Dwell Time: 1 sec

Range (MHz)	Field	Modulation	Polarity	Position	Test Performance	Result
80-1000	3V/m	AM	H	Front	No function loss	A
80-1000	3V/m	AM	H	Left	No function loss	A
80-1000	3V/m	AM	H	Back	No function loss	A
80-1000	3V/m	AM	H	Right	No function loss	A
80-1000	3V/m	AM	V	Front	No function loss	A
80-1000	3V/m	AM	V	Left	No function loss	A
80-1000	3V/m	AM	V	Back	No function loss	A
80-1000	3V/m	AM	V	Right	No function loss	A

### 11.3. PERFORMANCE & RESULT

<b>Criteria A:</b>	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
<b>Criteria B:</b>	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
<b>Criteria C:</b>	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**PASS**

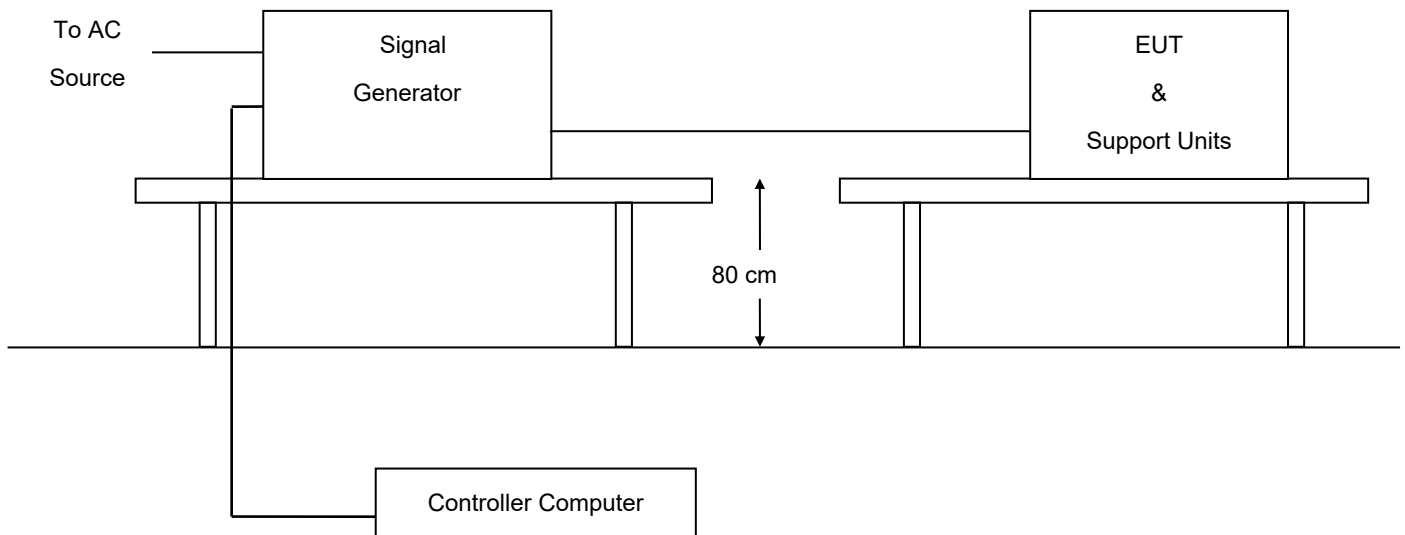
**FAIL**

## 12. EN 61000-4-8 PFMF TEST

### POWER FREQUENCY MAGNETIC FIELDS IMMUNITY TEST

<b>Port</b>	Enclosure
<b>Basic Standard</b>	EN 61000-4-8
<b>Requirements</b>	50/60 Hz, 3A/m
<b>Standard require</b>	A
<b>Tester</b>	Erik
<b>Temperature</b>	25 °C
<b>Humidity</b>	55%

#### 12.1. BLOCK DIAGRAM OF TEST SETUP



## 12.2. TEST PROCEDURE

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m × 1m). The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

### Test Conditions:

Frequency	Polarity	Level	Test Performance	Performance Result
50 Hz	X	3 A/m	No function loss	A
50 Hz	Y	3 A/m	No function loss	A
50 Hz	Z	3 A/m	No function loss	A

## 12.3. PERFORMANCE & RESULT

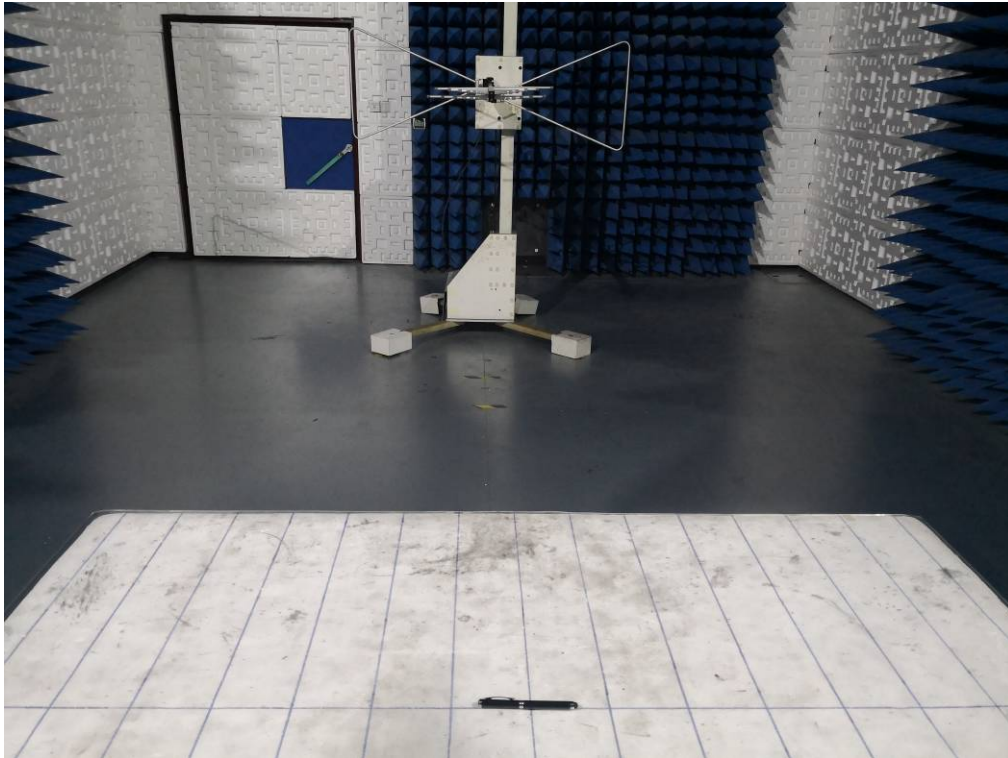
<b>Criteria A:</b>	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
<b>Criteria B:</b>	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
<b>Criteria C:</b>	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**PASS**

**FAIL**

## APPENDIX A: PHOTOGRAPHS OF TEST SETUP

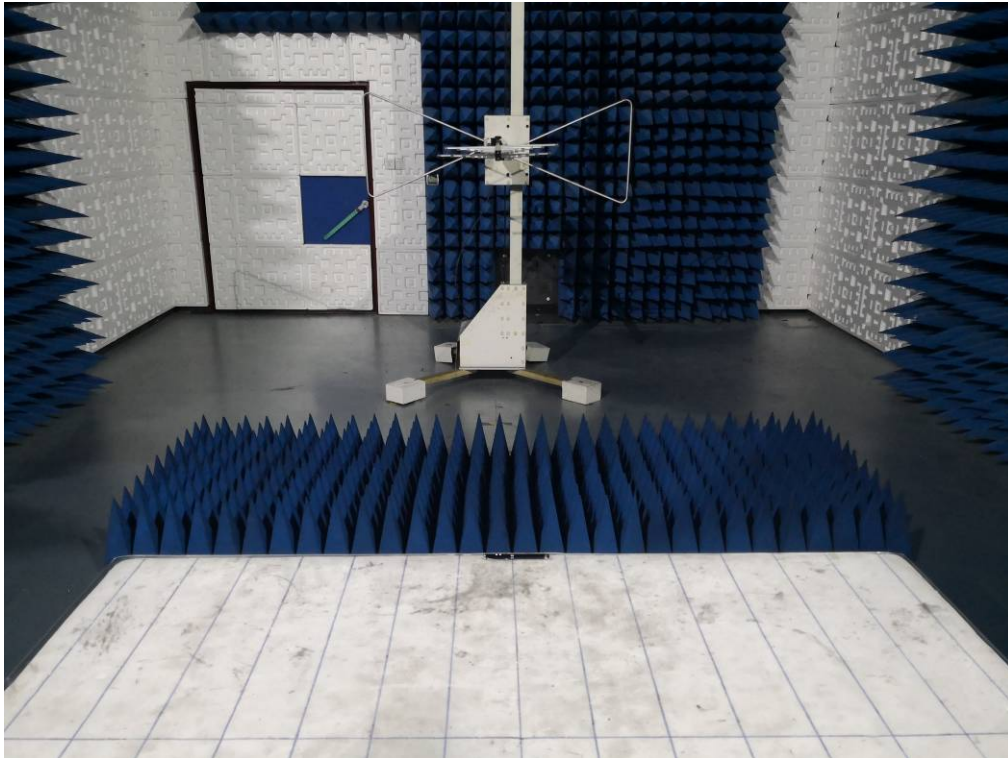
### EN 55015 RADIATED EMISSION TEST SETUP



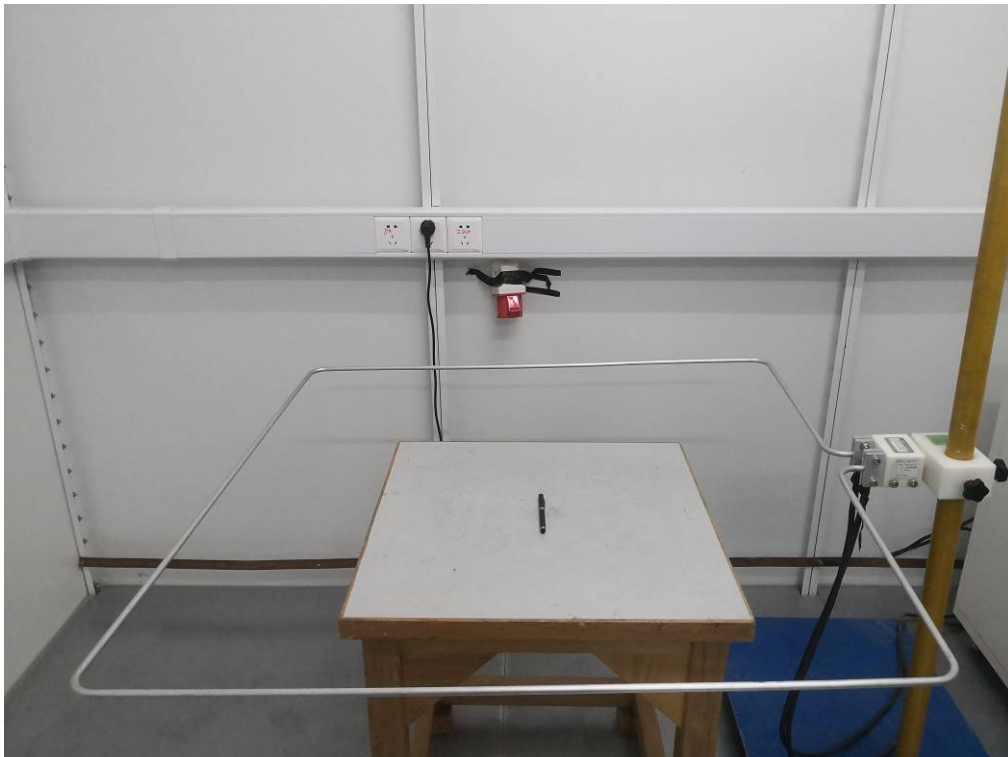
### EN 61000-4-2 ESD IMMUNITY TEST SETUP



EN 61000-4-3 RS IMMUNITY TEST SETUP



EN 61000-4-8 PFMF IMMUNITY TEST SETUP



## APPENDIX B: PHOTOGRAPHS OF EUT

ALL VIEW OF EUT-1



ALL VIEW OF EUT-2





ALL VIEW OF EUT-3



TOP VIEW OF EUT



BOTTOM VIEW OF EUT



FRONT VIEW OF EUT



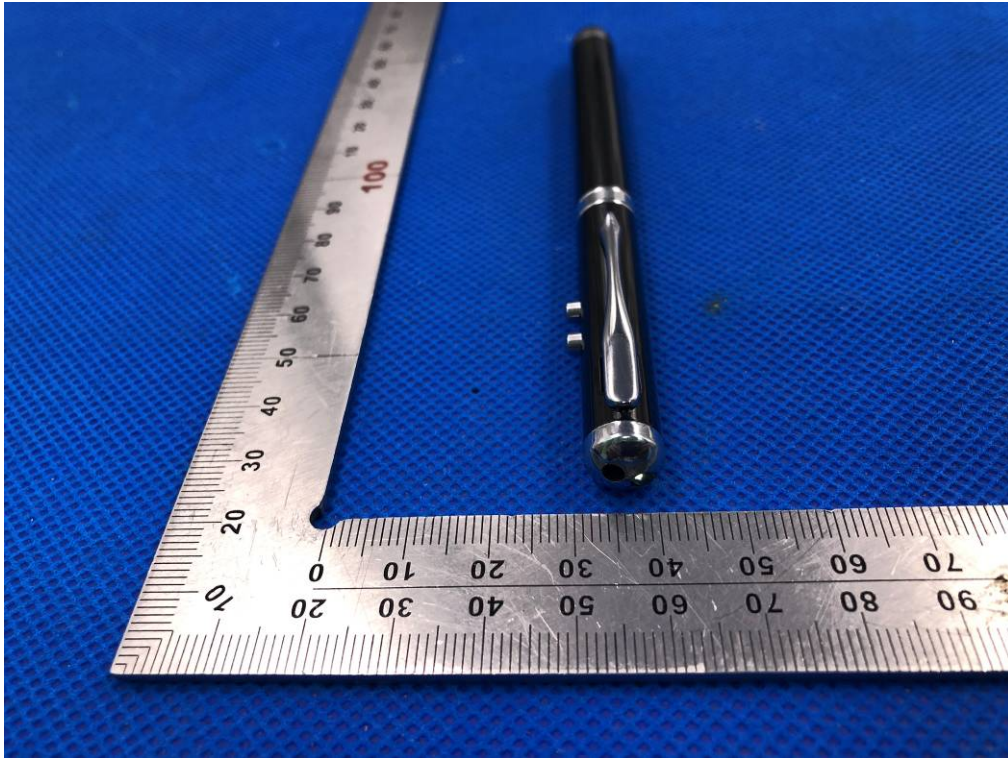
BACK VIEW OF EUT



LEFT VIEW OF EUT



RIGHT VIEW OF EUT



OPEN VIEW OF EUT



----END OF REPORT----